Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/509,409	HOELEN ET AL.
Examiner .	Art Unit
 Lee Y Quach	2875

SEARCHED				
Class	Subclass	Date	Examiner	
362	27 601 606 607 612 613 615 623 624 625	1/31/2006	YMY	
	626 628			
349	62 65			
-				

INT	ERFERENCI	E SEARCI	HED
Class	Subclass	Date	Examiner
	·		

SEARCH I (INCLUDING SEAR	NOTES CH STRATEGY)
	DATE	EXMR
IONE	1/31/2006	YMY
		_
		-